


<b>Search Notes</b>  	<b>Application/Control No.</b>  09650355	<b>Applicant(s)/Patent Under Reexamination</b>  BASSO ET AL.
	<b>Examiner</b>  Huynh, Son P	<b>Art Unit</b>  2424

### SEARCHED

Class	Subclass	Date	Examiner
	UPDATE SEARCH	12/29/06	AH
725;705	23,32-36, 13; 145	12/29/06	AH
update search		9/26/07	AH
725	46	9/26/07	AH
update search		3/18/08	AH
	update search performed	10/11/08	AH
	update search performed	1/27/09	AH
	update search performed	6/16/09	AH
	update previous search	12/31/09	AH
	update previous search	6/14/10	AH
715	723	6/14/10	AH
	update search	10/09/10	AH
	update previous searched	3/8/11	AH

### SEARCH NOTES

Search Notes	Date	Examiner
EAST TEXT SEARCH ENCLOSED	12/29/06	AH
UPDATED EAST TEXT SEARCH ENCLOSED	9/26/07	AH
update East text search enclosed	3/18/08	AH
UPDATE EAST text search enclosed	10/11/08	AH
Update EAST text search enclosed	1/27/09	AH
update EAST text search enclosed	6/16/09	AH
Update EAST text search enclosed	12/31/09	AH
Nhan Tran (348), Allen Wong (348)	6/10/10	AH
Update EAST text search enclosed	6/15/10	AH
EAST text search enclosed	10/9/10	AH
Inventors and assignee searched	3/7/11	AH
EAST text search enclosed	3/7/11	AH

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
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	/SON P HUYNH/ Primary Examiner.Art Unit 2424
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**INTERFERENCE SEARCH**

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
725	23,32-36, 46, 135	3/7/11	AH
705	14	3/7/11	AH
715	723	3/7/11	AH
	Interference EAST text search enclosed	3/7/11	AH

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